

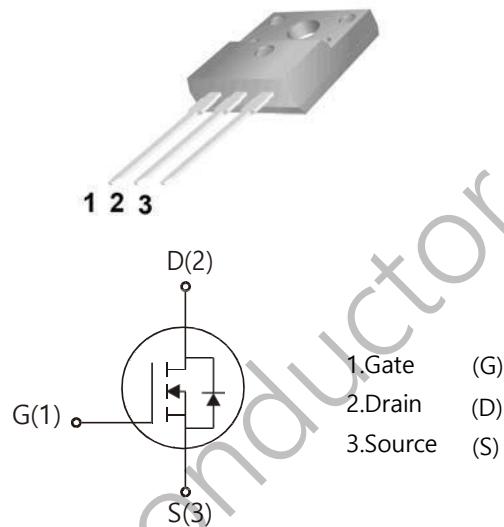


WGF70R490

Features:

- Low Intrinsic Capacitances.
- Excellent Switching Characteristics.
- Extended Safe Operating Area.
- Unrivalled Gate Charge : $Q_g = 8.7\text{nC}(\text{Typ.})$.
- $V_{DSS} = 700\text{ V}, I_D = 8\text{A}$
- $R_{DS(on)} : 0.55\ \Omega (\text{Max}) @ V_G = 10\text{V}$

TO-220F



Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	700	V
I_D	Drain Current	$T_j = 25^\circ\text{C}$	8.0
		$T_j = 100^\circ\text{C}$	5.0
V_{GSS}	Gate-Source Voltage	± 30	V
E_{AS}	Single Pulse Avalanche Energy (note1)	140	mJ
I_{DM}	Pulsed Drain Current (note2)	24	A
P_D	Power Dissipation ($T_j = 25^\circ\text{C}$)	26	W
T_j	Junction Temperature (Max)	150	$^\circ\text{C}$
T_{stg}	Storage Temperature	-55~+150	$^\circ\text{C}$
dv/dt	MOSFET dv/dt ruggedness, $V_{DS} = 0\text{V}...480\text{V}$	50	V/ns

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JC}$	Thermal Resistance Junction to Case	-	4.8	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	-	62.5	$^\circ\text{C/W}$

Electrical Characteristics (Ta=25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Off Characteristics						
BVDSS	Drain-Source Breakdown Voltage	Id=250µA , VGS =0	700	-	-	V
△BVDSS/ △TJ	Breakdown Voltage Temperature Coefficient	Id=250µA , Reference to 25°C	-	0.67	-	V/°C
IDSS	Zero Gate Voltage Drain Current	VDS=700V, VGS =0V	-	-	10	µA
		VDS=520V, TJ=125°C			100	
IGSSF	Gate-body leakage Current, Forward	VGS =+30V, VDS=0V	-	-	100	nA
IGSSR	Gate-body leakage Current, Reverse	VGS =-30V, VDS=0V	-	-	-100	
On Characteristics						
VGS(TH)	Date Threshold Voltage	Id=250µA,V S=VGS	2	-	4	V
RDS(ON)	Static Drain-Source On-Resistance	D=4.0A,VGS =10V	-	0.49	0.55	Ω
Dynamic Characteristics						
Ciss	Input Capacitance	VDS=25V , VGS =0 , f=1.0MHz	-	410.8	-	pF
Coss	Output Capacitance		-	41.7	-	
Crss	Reverse Transfer Capacitance			3.1	-	
Switching Characteristics						
Td(on)	Turn-On Delay Time	VDD=400V , Id=4A Rg =25Ω (Note 3,4)	-	26.4		nS
Tr	Turn-on Rise Time		-	17.9		
Td(of f)	Turn-Off Delay Time		-	56.2		
Tf	Turn-Off Rise Time		-	14.0		
Qg	Total Gate Charge	VDS=400V,VGS =10V , Id=5A (Note3,4)	-	8.6		nC
Qgs	Gate-Source Charge		-	2.2	-	
Qgd	Gate-Drain Charge		-	3.8	-	
Drain-Source Diode Characteristics and Maximum Ratings						
Is	Max. Diode Forward Current	-	-	-	8	A
ISM	Max. Pulsed Forward Current	-	-	-	24	
VSD	Diode Forward Voltage	Id=8A	-	-	1.3	V
Trr	Reverse Recovery Time	Is=4A,VGS =0V diF/dt=100A/µs (Note3)	-	214.3	-	nS
Qrr	Reverse Recovery Charge		-	1.7	-	µC

Note

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) Pd is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of RθJA is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with Ta=25 °C.
- 5) VDD=100 V, VGS=10 V, L=79.9 mH, starting TJ=25 °C.

Typical Characteristics

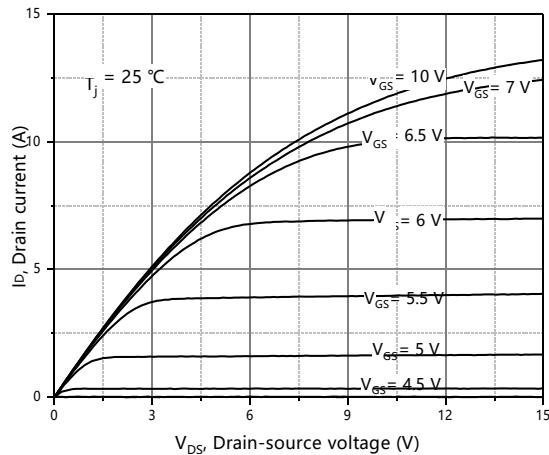


Figure 1. Typ. output characteristics

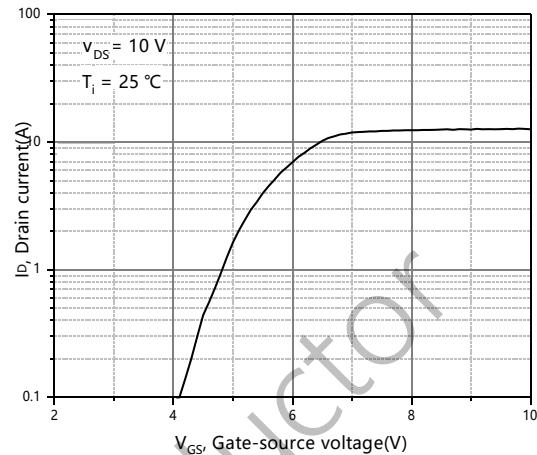


Figure 2. Typ. transfer characteristics

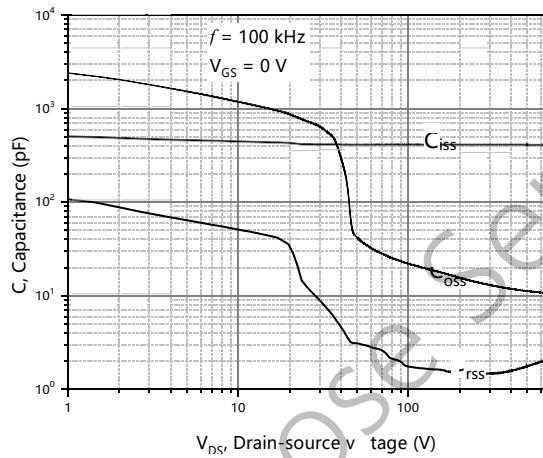


Figure 3. Typ. capacitances

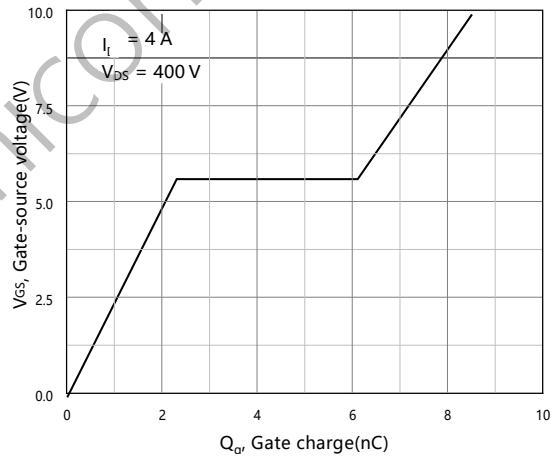


Figure 4. Typ. gate charge

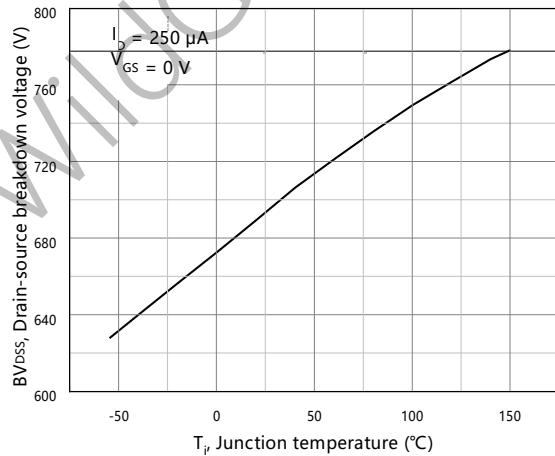


Figure 5. Drain-source breakdown voltage

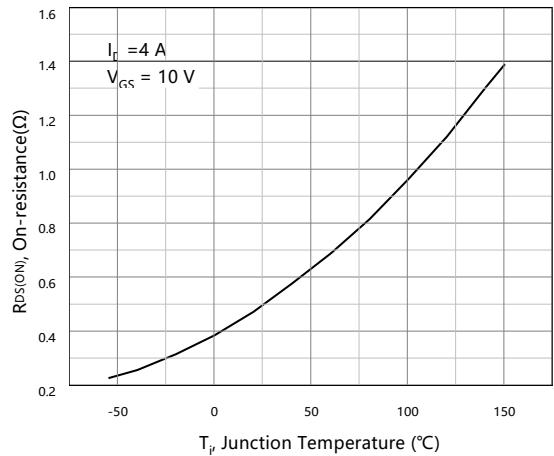


Figure 6. Drain-source on-state resistance

Typical Characteristics (Continued)

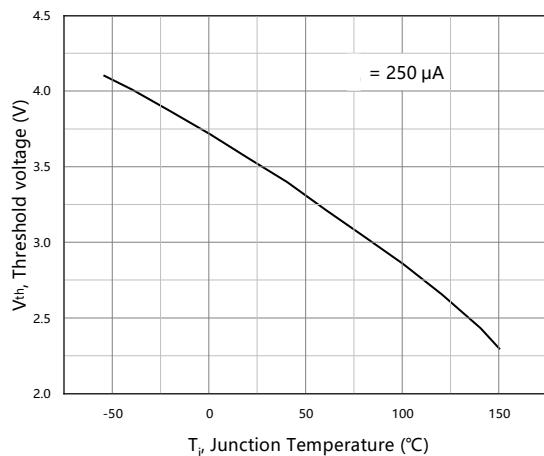


Figure 7. Threshold voltage

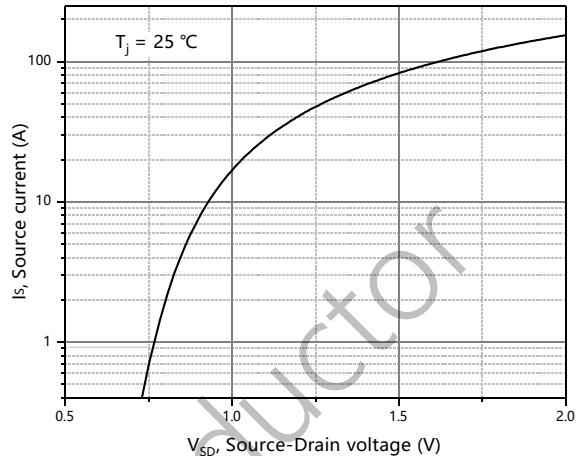


Figure 8. Forward characteristic of body diode

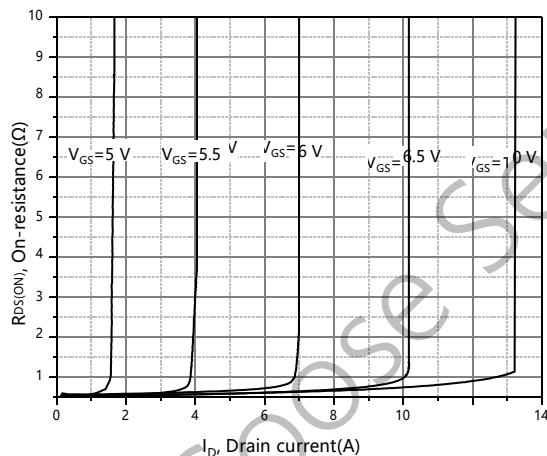


Figure 9. Drain-source on-state resistance

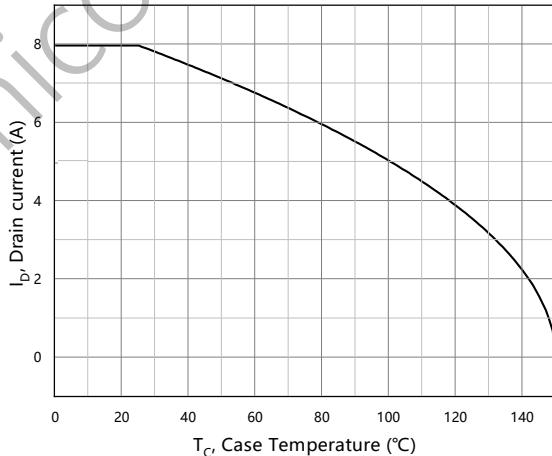
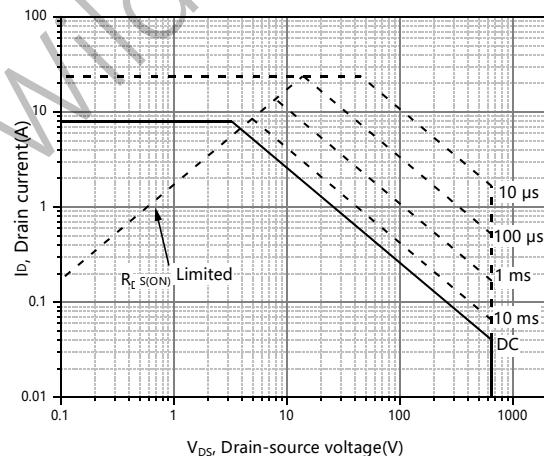
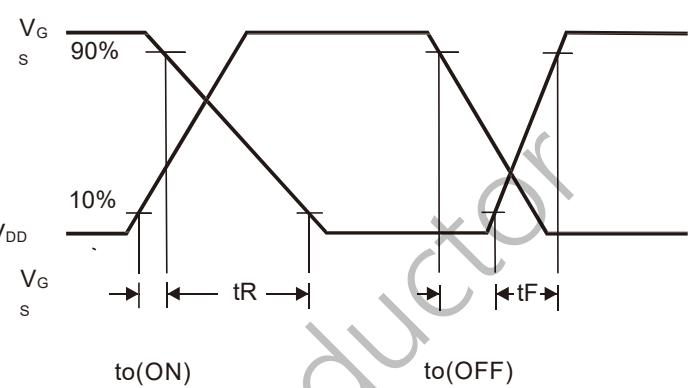
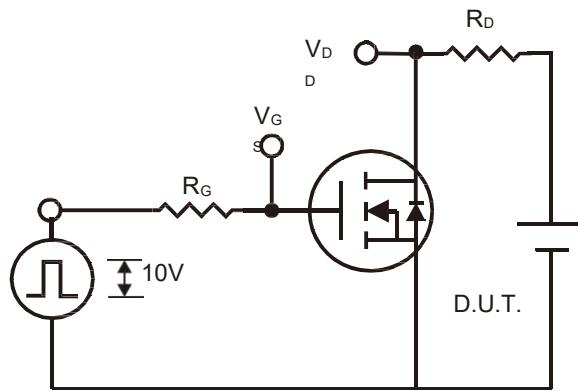


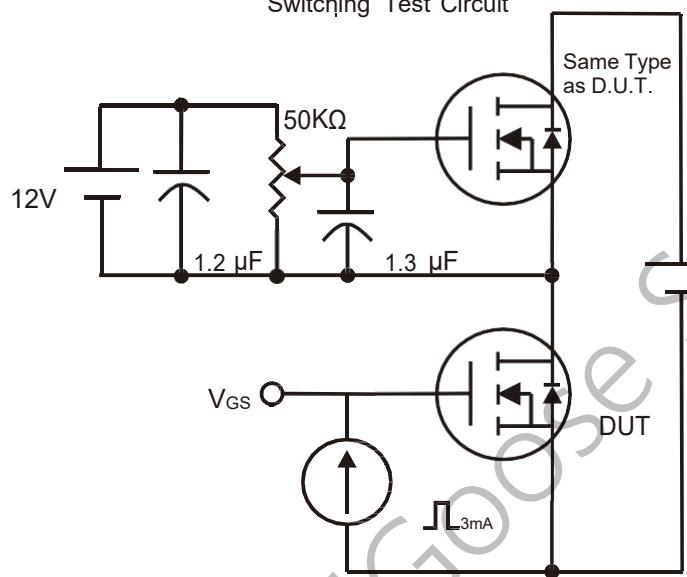
Figure 10. Drain current

Figure 11. Safe operation area $T_C=25^\circ\text{C}$

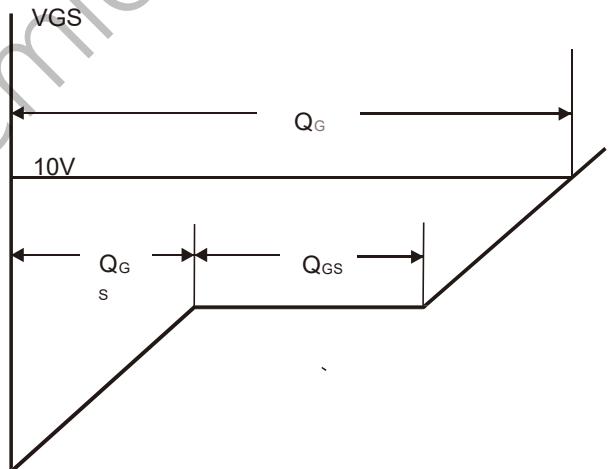
Gate Charge Test Circuit & Waveform



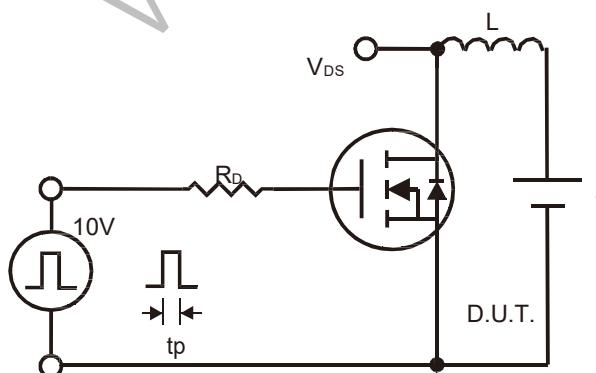
Switching Test Circuit



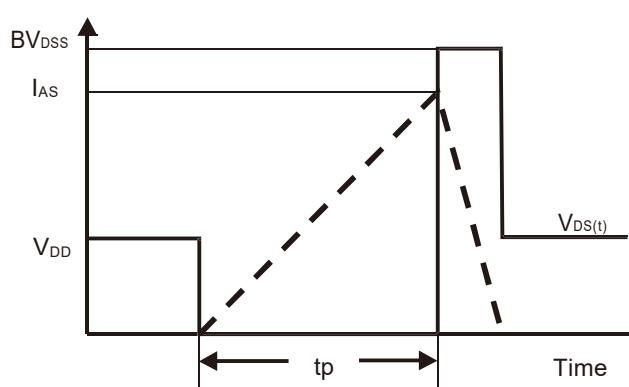
Switching Waveforms



Gate Charge Test Circuit



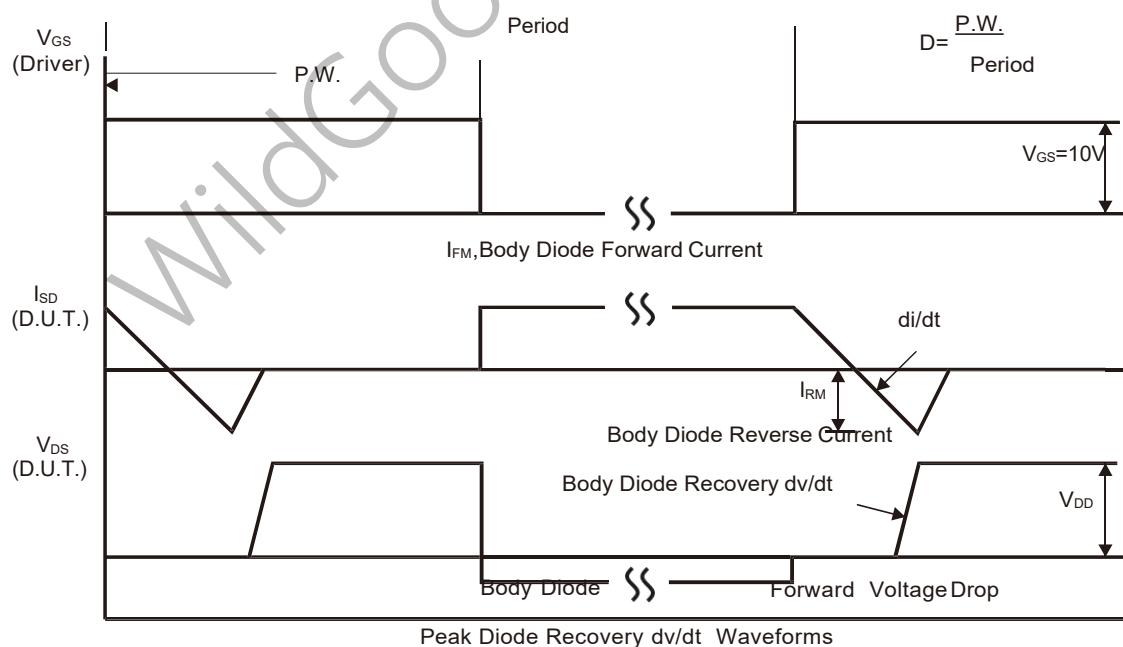
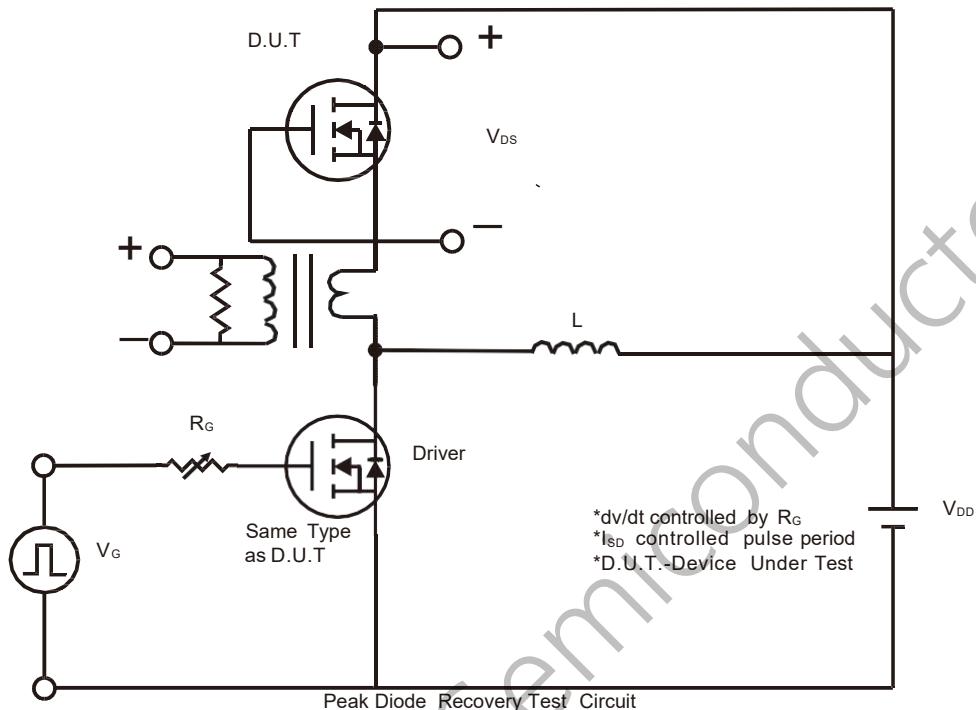
Gate Charge Waveform



Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

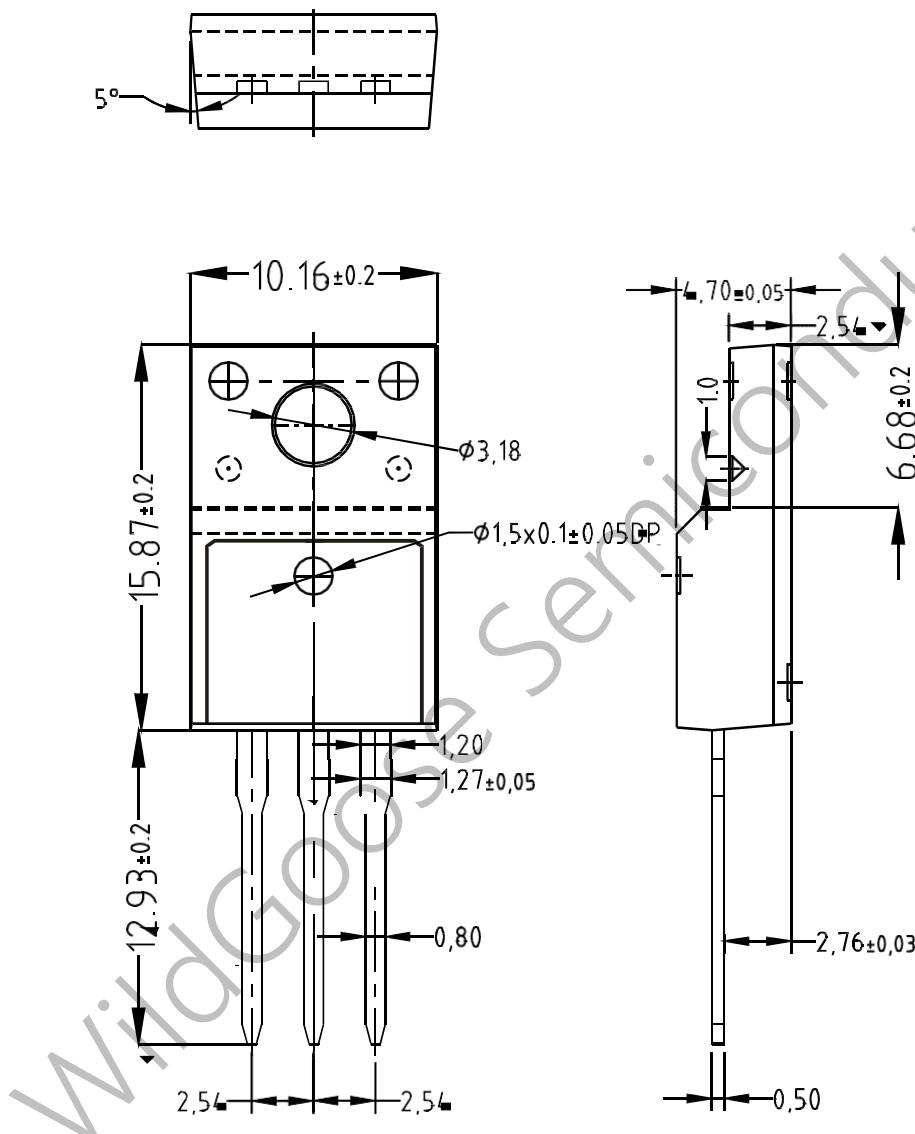
Peak Diode Recovery dv/dt Test Circuit & Waveform



Package Dimension

TO-220F

Unit: mm



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